## Application/Control No. Applicant(s)/Patent Under Reexamination 10/713,254 PARK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Sin J. Lee 1752 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,561,026	10-1996	Aoki, Nobuo	430/196
	В	US-2001/0050219 A1	12-2001	Anazawa et al.	204/173
	С	US-4,439,291	03-1984	Irving et al.	522/34
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	ı	US-			
	J	US-			·
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	В					
	S					
	T					

## **NON-PATENT DOCUMENTS**

TON I ALEM DOGGLETTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.